

FAST CMOS OCTAL BUFFER/LINE DRIVER

IDT54/74FCT244T/AT/CT

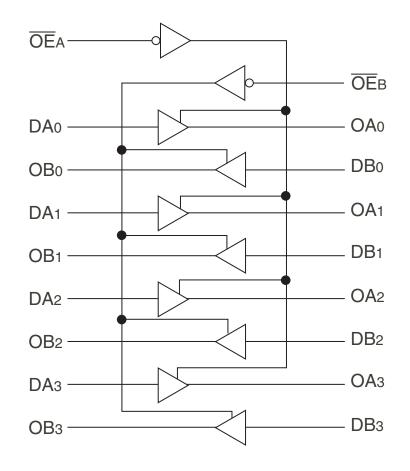
FEATURES:

- Std., A, and C grades
- Low input and output leakage ≤1µA (max.)
- CMOS power levels
- True TTL input and output compatibility:
 - -VOH = 3.3V (typ.)
 - -VOL = 0.3V(typ.)
- High Drive outputs (-15mA IOH, 64mA IOL)
- · Meets or exceeds JEDEC standard 18 specifications
- Military product compliant to MIL-STD-883, Class B and DESC listed (dual marked)
- · Power off disable outputs permit "live insertion"
- · Available in the following packages:
 - Industrial: SOIC, SSOP, QSOP, TSSOP
 - Military: CERDIP, LCC

DESCRIPTION:

The IDT octal buffer/line driver is built using an advanced dual metal CMOS technology. The FCT244T is designed to be employed as a memory and address driver, clock driver, and bus-oriented transmitter/ receiver which provides improved board density.

FUNCTIONAL BLOCK DIAGRAM

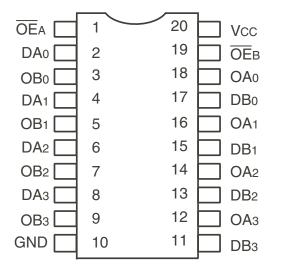


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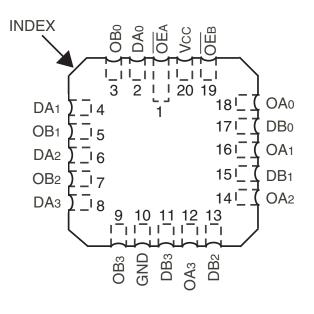
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DECEMBER 2016

PINCONFIGURATION







LCC TOP VIEW

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

Symbol	Description	Max	Unit	
VTERM ⁽²⁾	Terminal Voltage with Respect to GND	–0.5 to +7	V	
VTERM ⁽³⁾	M ⁽³⁾ Terminal Voltage with Respect to GND –0.5 to Vcc+0.5			
Tstg	Storage Temperature	-65 to +150	°C	
Ιουτ	DC Output Current	-60 to +120	mA	

NOTES:

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability. No terminal voltage may exceed Vcc by +0.5V unless otherwise noted.
- 2. Inputs and Vcc terminals only.
- 3. Output and I/O terminals only.

CAPACITANCE (TA = +25°C, F = 1.0MHz)

Symbol	Parameter ⁽¹⁾	Conditions	Тур.	Max.	Unit	
CIN	Input Capacitance	VIN = 0V	6	10	pF	
Соит	Output Capacitance	Vout = 0V	8	12	pF	

NOTE:

1. This parameter is measured at characterization but not tested.

PINDESCRIPTION

Pin Names	Description
OEA, OEB	3-State Output Enable Inputs (Active LOW)
Dxx	Inputs
Охх	Outputs

FUNCTION TABLE⁽¹⁾

	Inputs					
ŌĒA	OE B	D	Outputs			
L	L	L	L			
L	L	Н	Н			
Н	Н	Х	Z			

NOTE:

X = Don't Care

L = LOW Voltage Level

Z = High Impedance

^{1.} H = HIGH Voltage Level

DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified:

Industrial: TA = -40° C to $+85^{\circ}$ C, Vcc = 5.0V $\pm 5\%$; Military: TA = -55° C to $+125^{\circ}$ C, Vcc = 5.0V $\pm 10\%$

Symbol	Parameter	Tes	t Conditions ⁽¹⁾	Min.	Typ. ⁽²⁾	Max.	Unit
Vih	Input HIGH Level	Guaranteed Logic HIGH I	_evel	2	—	_	V
Vil	Input LOW Level	Guaranteed Logic LOW Logic	evel	_	_	0.8	V
Ін	Input HIGH Current ⁽⁴⁾	Vcc = Max.	VI = 2.7V		_	±1	μA
lil	Input LOW Current ⁽⁴⁾	Vcc = Max.	VI = 0.5V		_	±1	μA
Іоzн	High Impedance Output Current	Vcc = Max Vo = 2.7V		_	_	±1	μA
Iozl	(3-State output pins) ⁽⁴⁾		Vo = 0.5V		_	±1	
li	Input HIGH Current ⁽⁴⁾	Vcc = Max., VI = Vcc (N	lax.)	_	_	±1	μA
Vik	Clamp Diode Voltage	Vcc = Min, IIN = -18mA		—	-0.7	-1.2	V
Vн	Input Hysteresis	_		-	200	_	mV
Icc	Quiescent Power Supply Current	VCC = Max., VIN = GND	or Vcc	-	0.01	1	mA

OUTPUT DRIVE CHARACTERISTICS

Symbol	Parameter	Test Conditions ⁽¹⁾			Typ. ⁽²⁾	Max.	Unit
Vон	Output HIGH Voltage	Vcc = Min	Iон = –6mA MIL	2.4	3.3	-	
		VIN = VIH OF VIL	Iон = -8mA IND				V
			Iон = –12mA MIL	2	3	_	
			Iон = -15mA IND				
Vol	Output LOW Voltage	Vcc = Min	Iol = 48mA MIL	_	0.3	0.55	V
		VIN = VIH OF VIL	Iol = 64mA IND				
los	Short Circuit Current	Vcc = Max., Vo = GND ⁽³⁾		-60	-120	-225	mA

NOTES:

1. For conditions shown as Min. or Max., use appropriate value specified under Electrical Characteristics for the applicable device type.

2. Typical values are at Vcc = 5.0V, +25°C ambient.

3. Not more than one output should be tested at one time. Duration of the test should not exceed one second.

4. The test limit for this parameter is $\pm 5\mu A$ at TA = $-55^{\circ}C$.

POWER SUPPLY CHARACTERISTICS

Symbol	Parameter	Test Condition	ons ⁽¹⁾	Min.	Typ. ⁽²⁾	Max.	Unit
Δlcc	Quiescent Power Supply Current TTL Inputs HIGH	Vcc = Max. VIN = 3.4V ⁽³⁾		_	0.5	2	mA
ICCD	Dynamic Power Supply Current ⁽⁴⁾	Vcc = Max. Outputs Open $\overline{OEA} = \overline{OEB} = GND$ One Input Toggling 50% Duty Cycle	VIN = VCC VIN = GND	_	0.15	0.25	mA/ MHz
IC	Total Power Supply Current ⁽⁶⁾	Vcc = Max. Outputs Open fi = 10MHz	VIN = VCC VIN = GND	—	1.5	3.5	mA
		50% Duty Cycle $\overline{OE}A = \overline{OE}B = GND$ One Bit Toggling	VIN = 3.4V VIN = GND	—	1.8	4.5	
		Vcc = Max. Outputs Open fi = 2.5MHz	Vin = Vcc Vin = GND	—	3	6(5)	
		50% Duty Cycle $\overline{OE}A = \overline{OE}B = GND$ Eight Bits Toggling	Vin = 3.4V Vin = GND	_	5	14(5)	

NOTES:

1. For conditions shown as Min. or Max., use appropriate value specified under Electrical Characteristics for the applicable device type.

2. Typical values are at Vcc = 5.0V, +25°C ambient.

3. Per TTL driven input; (VIN = 3.4V). All other inputs at Vcc or GND.

4. This parameter is not directly testable, but is derived for use in Total Power Supply Calculations.

5. Values for these conditions are examples of Δ Icc formula. These limits are guaranteed but not tested.

6. IC = IQUIESCENT + INPUTS + IDYNAMIC

IC = ICC + Δ ICC DHNT + ICCD (fCP/2+ fiNi)

Icc = Quiescent Current

 ΔIcc = Power Supply Current for a TTL High Input (VIN = 3.4V)

DH = Duty Cycle for TTL Inputs High

NT = Number of TTL Inputs at DH

ICCD = Dynamic Current caused by an Input Transition Pair (HLH or LHL)

fcp = Clock Frequency for Register Devices (Zero for Non-Register Devices)

fi = Output Frequency

Ni = Number of Outputs at fi

All currents are in milliamps and all frequencies are in megahertz.

			54FCT244T		54/74FCT244AT			54/74FCT244CT					
			M	il.	In	d.	N	il.	In	d.	М	il.	
Symbol	Parameter	Condition ⁽¹⁾	Min. ⁽²⁾	Max.	Min. ⁽²⁾	Max.	Min. ⁽²⁾	Max.	Min. ⁽²⁾	Max.	Min. ⁽²⁾	Max.	Unit
tPLH .	Propagation Delay	CL = 50pF	1.5	7	1.5	4.8	1.5	5.1	1.5	4.1	1.5	4.6	ns
t PHL	Dx to Ox	$RL = 500\Omega$											
t PZH	Output Enable Time		1.5	8.5	1.5	6.2	1.5	6.5	1.5	5.8	1.5	6.5	ns
tPZL													
tphz	Output Disable Time		1.5	7.5	1.5	5.6	1.5	5.9	1.5	5.2	1.5	5.7	ns
tPLZ													

SWITCHING CHARACTERISTICS OVER OPERATING RANGE

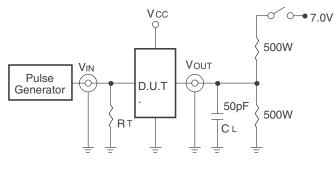
NOTES:

1. See test circuit and waveforms.

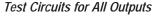
2. Minimum limits are guaranteed but not tested on Propagation Delays.

IDT54/74FCT244T/AT/CT FASTCMOSOCTAL BUFFER/LINEDRIVER

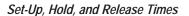
TEST CIRCUITS AND WAVEFORMS

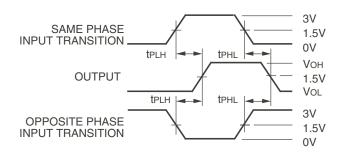


Octal Link



DATA 🔽 1.5V 0V INPUT tsu tн ЗV TIMING 1.5V 0V INPUT ASYNCHRONOUS CONTROL **t**REM PRESET ЗV 1.5V 0V CLEAR ETC. SYNCHRONOUS CONTROL ЗV PRESET 1.5V 0V CLEAR tsu тн CLOCK ENABLE ETC. Octal Link





Propagation Delay

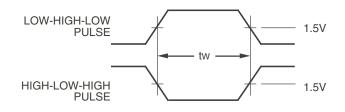
SWITCHPOSITION

Test	Switch
Open Drain Disable Low Enable Low	Closed
All Other Tests	Open

DEFINITIONS:

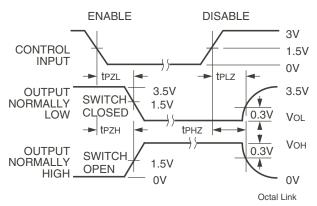
CL = Load capacitance: includes jig and probe capacitance.

RT = Termination resistance: should be equal to Zout of the Pulse Generator.



Pulse Width

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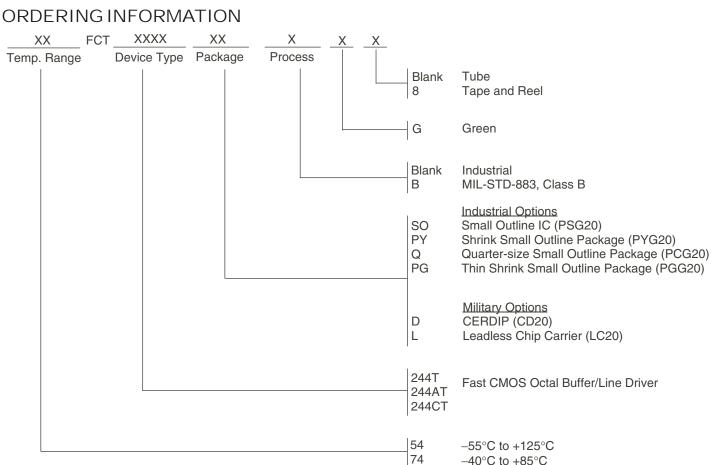


Enable and Disable Times

NOTES:

- 1. Diagram shown for input Control Enable-LOW and input Control Disable-HIGH.
- 2. Pulse Generator for All Pulses: Rate \leq 1.0MHz; tr \leq 2.5ns; tr \leq 2.5ns.

Octal Link



-40°C to +85°C

MILITARY AND INDUSTRIAL TEMPERATURE RANGES

Datasheet Document History

IDT54/74FCT244T/AT/CT

FASTCMOSOCTAL BUFFER/LINE DRIVER

09/29/2009 Pg. 6 Updated the ordering information by removing the "IDT" notation and non RoHS part. 12/12/2016 Pg. 6. Updated the ordering information by adding detailed package information and Tape & Reel.

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